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2875

## PATENT APPLICATION

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:	)	Examiner: P. J. Macchiarolo
KAZUSHI NOMURA	;	
Application No.: 09/955,137	;	Group Art Unit: 2875
Filed: September 19, 2001	; )	
For: ELECTRON-EMITTING DEVICE, ELECTRON SOURCE, IMAGE FORMING APPARATUS, AND	;	•
ELECTRON-EMITTING APPARATUS	:	January 16, 2004

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

## INFORMATION DISCLOSURE STATEMENT

Sir:

In compliance with the duty of disclosure under 37 C.F.R. § 1.56 and in accordance with the practice under 37 C.F.R. §§ 1.97 and 1.98, the Examiner's attention is directed to the documents listed on the enclosed Form PTO-1449. Copies of the listed documents are also enclosed.

For a concise explanation of relevance for various non-English documents listed on the enclosed Form PTO-1449, the Examiner is directed to the corresponding English-language abstracts, English translations, and/or English counterparts, where available, as indicated in association with the relevant non-English documents on the Form PTO-1449.

For the concise statement of relevance of non-English document CN 1181607A, the Examiner also is respectfully referred to English-language counterparts EP 0 836 217 A1 and WO 99/58748.

The Examiner's attention is also directed to the following U.S. Applications:

APPLICATION NO.	FILING DATE	GROUP ART UNIT
09/506,289	2/18/00	2818
09/666,605	09/20/00	2811

A copy of each cited application is enclosed.

It is respectfully requested that the above information be considered by the Examiner and that a copy of the enclosed Form PTO-1449 be returned indicating that such information has been considered.

Applicant's undersigned attorney may be reached in our New York office by telephone at (212) 218-2100. All correspondence should continue to be directed to our address given below.

Respectfully submitted,

Attorney for Applicant

Registration No. 42,476

FITZPATRICK, CELLA, HARPER & SCINTO 30 Rockefeller Plaza
New York, New York 10112-3801
Facsimile: (212) 218-2200

NY MAIN\_#384949v1

FORM PTO 1449 (modified)

Date Submitted to PTO:[DATE]

JAN 2 0 2004

TY DOCKET NO. 03500.015809. APPLICATION NO.

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

LIST OF REFERENCES CITED BY APPLICANT SADEMARY

(Use several sheets if necessary)

APPLICANT

Kazushi Nomura

FILING DATE

**September 19, 2001** 

GROUP 2875

09/955,137

			U.S. PATENT DOCUMENTS			
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	5,872,422	02/99	Xu et al.	313	311	
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<sup>\*</sup>EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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FORM PTO 1449 (modified)  U.S. DEPARTMENT OF COMME	-R&F	унтту доскет No. 03500.015809.	APPLICATION NO. 09/955,137	
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TY DOCKET NO. 03500.015809.

APPLICANT

APPLICATION NO.

09/955,137

2875

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

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Kazushi Nomura

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FORM PTO 1449 (modified)	ATTY DOCKET NO.	APPLICATION NO.	
U.S. DEPARTMENT OF COMMERCE	03500.015809.	09/955,137	
PATENT AND TRADEMARK OFFICE	APPLICANT		
LIST OF REFERENCES CITED BY APPLICANT(S)	Kazushi Nomura		

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PATENT AND TRADEMARK OFFICE	APPLICANT  Kazushi Nomura		
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	10-149760	06/02/98	Japan	H01J	1/30	Abst. & Counterpart U.S. Patent 6,097,138
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Sheet 7 of \_7

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